

Search Notes

Application/Control No.

10/623,880

Examiner

Young J. Kim

Applicant(s)/Patent under
Reexamination

BARNETT ET AL.

Art Unit

1637

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC - SEQ ID NO: 1 in Commercial, issued-patent, and PG-PUB databases.	9/14/2005	YJK
Standard oligomer search; and length-limited oligomer search - size "19" for SEQ ID NO: 1 and size "20" for SEQ ID NO. 27.	9/14/2005	YJK